

<b>Notice of References Cited</b>	Application/Control No. 10/747,846		Applicant(s)/Patent Under Reexamination LEE, GEUN IL	
	Examiner Reba I. Elmore		Art Unit 2189	Page 1 of 1

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*	B	US-6,681,301	01-2004	Mehta et al.	711/154
*	C	US-6,785,189	08-2004	Jacobs et al.	365/233
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	'General DDR SDRAM Functionality', Micron Technical Note, TN-46-05, pages 1-11, Micron Technology Inc., 2001.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.